

ATE

5200 Power Manufacturing Defects Analyzer



AEROFLEX
A passion for performance.

A range of Power Manufacturing Defects Analyzers offering the highest throughput capability to the electronics manufacturing industry.

- Up to 1200 components/sec test speed
- Maximum of 2112 pins
- Microsoft Windows™ operating system
- Power-up testing with programmable supply option
- Automatic program generation software
- Graphical program debug capability
- Autodebug facility
- Optional functional test capability
- Inductive and capacitive vectorless test
- 19 in rack mountable

The 5200 Series is the fastest analog test system available, combining high speed and the ability to accurately test a wide range of component types, effectively blurring the line between MDA, or analog In-Circuit, and full digital In-Circuit. This capability minimizes the investment in test systems by reducing the number of platforms required to achieve throughput, and providing the highest level of test coverage within a single manufacturing stage.

The system is controlled by an industry standard PC, with a Windows XP™ operating system. The 5200 Series has a small footprint allowing simple integration into automated in-line manufacturing facilities. The worldwide support and service capability offered by Aeroflex Limited places the 5200 Series as the preferred solution for analogue In-Circuit testing.

Architecture

The testframe of the 5200 Series is 19 in rack mountable containing eleven slots for testpoint cards, and a further three to take a range of functional resources. Each testpoint card offers 192 pins, interfaced to the test fixture through interconnection cabling. This approach provides the user with the ability to integrate the system into an in-line handler or use a range of fixturing with a human operator.

Advanced Test Techniques

Test techniques such as analog In-Circuit, boundary scan and functional ensure the highest level of fault coverage. Although by definition, a Manufacturing Defects Analyzer does not provide digital device testing through testpoint memory, the 5200 Series features a digital capability through the use of boundary scan and vectorless tools.

Vectorless Test Capability

Aeroflex Limited is unique in offering both inductive and capacitive vectorless techniques, ensuring wide test coverage across a range of components from complex ASICs to connectors. Inductive probing is performed using the Aeroflex patented Q-Test II technique, whilst capacitive tests use the industry standard HP TestJet™ probe. These two techniques contribute to the systems ability to generate tests for complex devices quickly, and to accurately diagnose faults to enhance productivity and quality.

For the very latest specifications visit www.aeroflex.com

Power-Up Testing

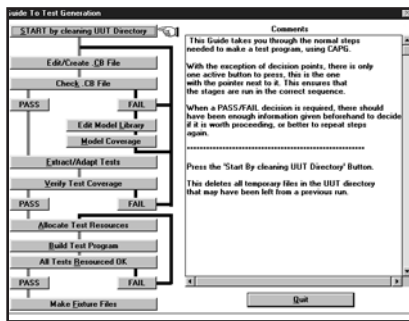
Boards are powered-up using either the programmable or fixed supplies. This enables the system to test a wide range of components, such as relays and op-amps, which would otherwise remain untested. This approach gives a vast advantage over conventional MDA systems, detecting a higher level of faults before further costs are incurred by allowing faulty product to progress along the production process.

Links to Computer Aided Design

Test programs are generated from CAD data or through a manual input tool for PCBs without electronic design data. The Aeroflex FABmaster package acts as the link to CAD formats, providing a quick and effective conversion process to improve time-to-market issues.

Automatic Program Generation

The 5200 Series' program generation software enables fixtures to be manufactured using an automated drilling and wiring process, and minimizes the test commissioning time through the use of a guarding simulator.



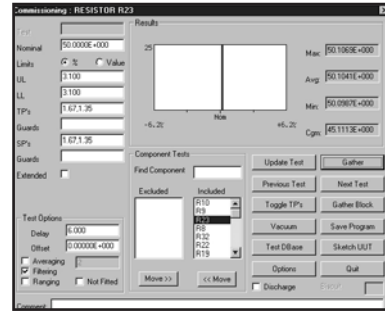
Test Program Guide

Autodebug

This facility is designed to improve time-to-market by using automatic debug algorithms, independent of the programmer. By altering the range of measurement parameters and analyzing the subsequent results across a number of reiteration modes, the autodebug facility is able to quickly commission a high proportion of analog In-Circuit tests.

Graphical Program Debug

A simple 'point & click' Graphical User Interface is used during the commissioning of the program and fixture. Tests can be run for individual devices, blocks of components, or as a complete program. The interface enables simple selection of component values, limits, test and sense points, delays and frequencies. Results are shown graphically allowing the user to determine the stability and accuracy of each measurement. Measure stability analysis is further enhanced by the integrated CGM facility demanded by quality standards.



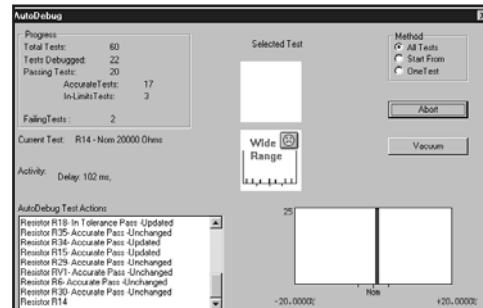
Commissioning Window

Component Failure Identification

A graphical representation of the unit under test provides visual positioning for each component during the debug phase. User selectable options provide, amongst others, the facility to rotate and flip the board representation.

Functional Capability

A range of functional test cards can be fitted to the 5200 Series, further enhancing the high level of fault coverage provided. In many cases, this functional capability will negate the use of further test equipment within the production line by trapping faults at an early stage. The 5200 Series throughput capability often allows this approach to be used as the pure MDA test is well within the beat rate of the production facility.



Autodebug Screen

Upgrade Options

As is common across the range of Aeroflex test systems, the 5200 Series offers a wide range of upgrades for both new and existing customers. Users of the earlier 5200 system can upgrade to 5220 through the fitting of a new backplane.

Dual Vacuum Interface

The latest model in the 5200 range is the 5221. This now includes as a standard feature a Dual Vacuum Control Interface. This allows increased throughput in a volume manufacturing environment to be obtained by the use of a dual chamber test fixture.

SPECIFICATION

MEASUREMENTS

Test Points

Base system, 384 pins core, expandable to 2112

Component Test Speed

Up to 1200 components / second

Capacitor discharge

Shorts & opens continuity test

DC Voltage measurement

10 mV - 50 V

DC Current measurement

10 nA - 100 mA

AC Voltage measurement

10 mV - 50 V

Resistance

20 m Ω - 200 M Ω

Capacitance

2 pF - 20 mF

Reversed Capacitor Detection

Inductance

2 μ H - 200 H

200 m Ω - 20 M Ω

Diode Tests

up to 20 V

Zener Diodes

up to 60 V

Transistors

on, off, leakage

FETs

on, off

Other components

Relays, Op-amps, Opto-isolators, Fuses, Links, LEDs Potentiometers, Thermistors, Switches, Thyristors Transformers, Voltage Regulators, Voltage References

Opens Detection

Capacitive, Inductive

STIMULUS

Two independent stimulus channels, AC or DC

DC

-10 V to +20 V, four quadrant, programmable

0 to 200 mA, programmable

AC

0 to 3.8 V pk-pk, programmable

Programmable DC offset -10 V to +10 V,

0 to 200 mA source or sink

Frequency range

0 to 100 kHz

UUT POWER SUPPLIES

One fixed 5 V, 6 A

Two Programmable 0.25 V to 30 V, 0.5 A to 2 A

GENERAL

POWER REQUIREMENTS

Single phase AC supply

Mains input

Auto range select

Nominal 220 V/240 V

198 V to 264 V

Nominal 100 V/120 V

99 V to 132 V

Supply frequency

47 Hz to 63 Hz

Power

0.5 kVA, maximum

Electromagnetic Compatibility

The 5200 complies with the limits specified in the following standards.

EN50081-1, Class A

EN50082-1

EN61000-3-2

Safety

The 5200 complies with IEC 1010, BSEN 61010-1 for class 1 equipment and is for use in a pollution degree 2 environment. The tester is designed to operate from an installation category 2 supply.

ENVIRONMENTAL CONDITIONS

Operating Temperature

10 to 35°C

Humidity

25% to 90% rh, non-condensing

Non-operating (Storage & Transport)

Temperature

-40 to +70°C

Humidity

Up to 93% rh, non-condensing

DIMENSIONS AND WEIGHT

Dimensions

445 mm (17") wide x 317 mm (12") high x 494 mm (19") deep

Weight

Typically 32 kg (70 lbs.) pin configuration dependent

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Our passion for performance is defined by three attributes represented by these three icons: solution-minded, performance-driven and customer-focused.